

P-Channel 40-V (D-S) MOSFET

Description

The device is using trench DMOS technology. This advanced technology has been especially tailored to minimize $R_{DS(ON)}$, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

Features

- $R_{DS(ON)} = 13m\Omega$ @ $V_{GS} = -10V$
- Fast switching
- Suit for -4.5V Gate Drive Applications
- 100% EAS Guaranteed
- Green Device

Typical Applications

- Notebook
- Load Switch
- Networking
- Hand-Held Instruments

Package type: PDFN 3.3X3.3

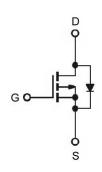
Packing & Order Information

3,000/Reel

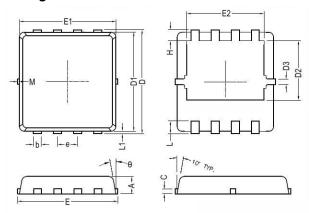


RoHS Compliant

Graphic Symbol

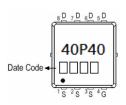


Package Dimension



REF.	Millimeter		REF.	Millimeter				
	Min.	Nom.	Max.	KEF.	Min.	Nom.	Max.	
Α	0.70	0.75	0.80	E1	3.00	3.15	3.20	
b	0.25	0.30	0.35	E2	2.39	2.59		
С	0.10	0.15	0.25	е	0.65 BSC			
D	3.25	3.35	3.45	Н	0.30	0.39	0.50	
D1	3.00	3.10	3.20	L	0.30	0.40	0.50	
D2	1.78	1.88	1.98	L1	-	0.13	0.20	
D3	-	0.13	=	θ	-	10°	12°	
Е	3.20	3.30	3.40	M	-	-	0.15	

Marking





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MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)						
Symbol	Parameter	Value	Unit			
V _{DS}	Drain-Source Voltage	-40	V			
V _G s	Gate-Source Voltage	±20	V			
ı	Continuous Drain Current¹ (Tc=25°C)	-40	А			
lo	Continuous Drain Current¹ (Tc=100°C)	-25	А			
Ірм	Pulsed Drain Current ^{1,2}	-160	А			
I _{AS}	Single Pulse Avalanche Current, L =0.1mH ³	-51	А			
Eas	Single Pulse Avalanche Energy, L =0.1mH ³	130	mJ			
Po	Power Dissipation ⁴ (T _C =25°C)	53	W			
T _J /T _{STG}	Operating Junction and Storage Temperature	-55 to 150	°C			

Thermal Resistance Ratings						
Symbol	Parameter	Value	Unit			
Reja	Maximum Junction-to-Ambient ¹	60	°C/W			
Rejc	Maximum Junction-to-Case	3.2	°C/W			

Electrical Characteristics (T _J =25°C unless otherwise specified)							
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units	
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250µA	-1.0	-1.6	-2.5	V	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	-40	-	-	V	
G fs	Forward Transconductance	V _{DS} =-10V, I _D =-5A	-	23	-	S	
I _{GSS}	Gate-Source Leakage Current	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA	
IDSS	Drain-Source Leakage Current	V _{DS} =-40V, V _{GS} =0V, T _J =25°C	-	-	-1	μA	
		V _{DS} =-32V, V _{GS} =0V, T _J =55°C	-	-	-10		
R _{DS(on)}	Static Drain-Source On-Resistance ²	V _{GS} =-10V, I _D =-20A	-	10	13	mΩ	
		V _{GS} =-4.5V, I _D =-10A	-	15	21		
E _{AS}	Single Pulse Avalanche Energy⁵	V _{DD} =25V, L =0.1mH, I _{AS} =40A	80	-	-	mJ	
V _{SD}	Diode Forward Voltage ²	I _S =-1A, V _{GS} =0V, T _J =25°C	-	-	-1.2	V	
Is	Continuous Source Current ^{1,6}	-V _G =V _D =0V, Force Current	-	-	-40	А	
I _{SM}	Pulsed Source Current ^{2,6}	7 vg – vp =0 v, Foice Current	-	-	-120		



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Dynamic and Switching Characteristics						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Qg	Total Gate Charge ²	V _{DS} =-20V		60		
Qgs	Gate-Source Charge	I _D =-20A		8.6		nC
Q _{gd}	Gate-Drain Charge	V _{GS} =-10V		13.9		
t _{d(on)}	Turn-On Delay Time ²	V _{DS} =-20V		18		
tr	Rise Time	$R_L = 1\Omega$		4.8		
t _{d(off)}	Turn-Off Delay Time	V _{GS} =-10V		88.5		ns
t f	Fall Time	$R_G = 3\Omega$		26		
Ciss	Input Capacitance	V _{DS} =-20V		3257		
Coss	Output Capacitance	V _{GS} =0V		230		pF
Crss	Reverse Transfer Capacitance	f =1.0MHz		197		

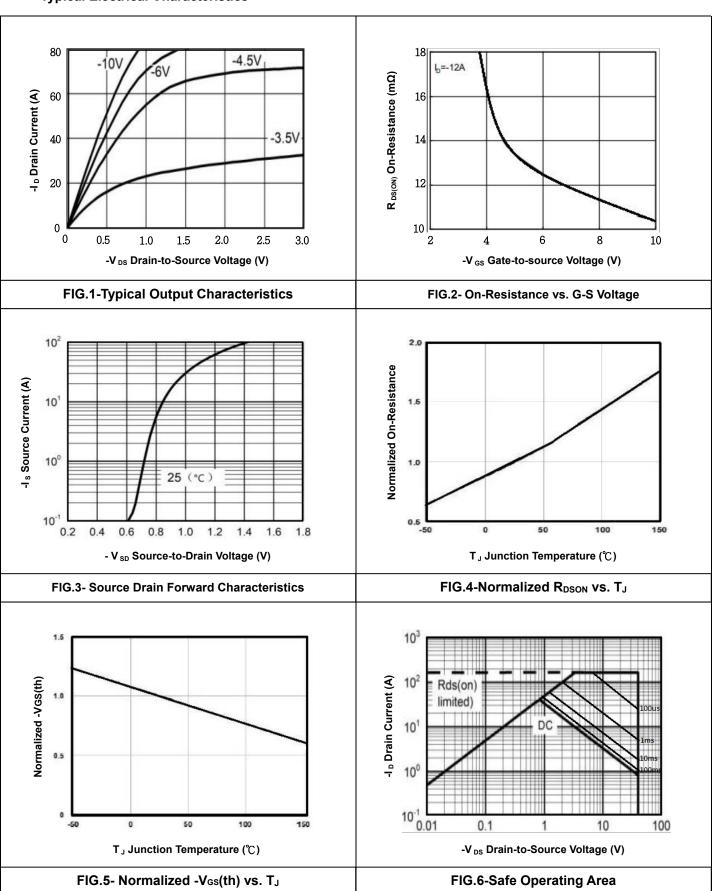
Notes

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2. The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%.
- 3. The EAS data shows maximum rating. The test condition is V_{DD} =-25V, V_{GS} =-10V, L=0.1mH, I_{AS} =-51A.
- 4. The power dissipation is limited by 150° C junction temperature.
- 5. The Min. value is 100% E_{AS} test guaranteed.
- 6. The data is theoretically the same as I_D and I_{DM}, in real applications, should be limited by total power dissipation.



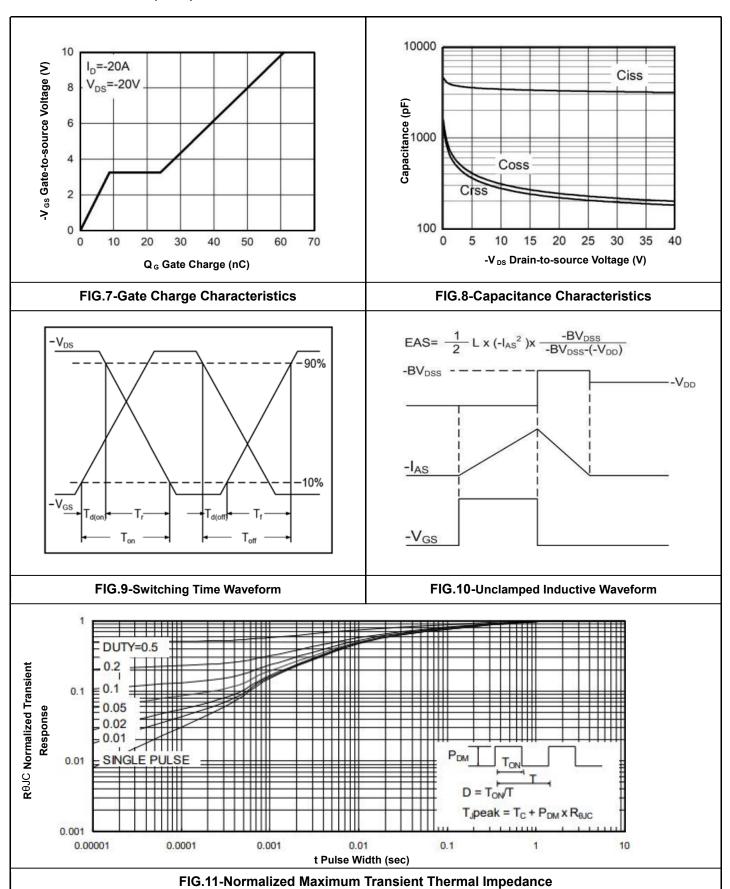
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• Typical Electrical Characteristics





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